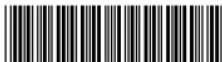


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|-----------------------------------------------------------------------------------|-------------------------|-----------------------------------------|
| Search Notes | Application/Control No. | Applicant(s)/Patent Under Reexamination |
|  | 10532446 | DE HAEN ET AL. |
| Examiner | Art Unit | |
| BRANDON J FETTEROLF | 1642 | |

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |

SEARCH NOTES

| Search Notes | Date | Examiner |
|-----------------------------------------------------------------------|----------|----------|
| WEST (see attached) PGPUB/USPAT/EPAB | 10/14/08 | BF |
| Inventor Search | 10/14/08 | BF |
| WEST (See attached) PGPUB/USPAT/EPAB | 4/26/09 | BF |
| Google/Scholar/Patents: KW TCEP (Syn), reduction, Fab frag, antibod., | 4/26/09 | BF |
| Inventor Search | 4/26/09 | BF |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |

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| | /BRANDON J FETTEROLF/ Primary Examiner. Art Unit 1642 |
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